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FR015L3EZ (15mΩ, -20V) Low-Side Reverse Bias / Reverse Polarity Protector

Features

- Up to -20V Reverse-Bias Protection
- Nano Seconds of Reverse-Bias Blocking Response Time
- +12V 24-Hour "Withstand" Rating
- 15mΩ Typical Series Resistance at 3.0V
- 18mΩ Typical Series Resistance at 2.1V
- Integrated TVS Over Voltage Suppression
- MicroFET2x2mm Package Size
- RoHs Compliant
- USB V_{BUS} Compatible

Applications

- 3V+ Battery Operated Systems
- Reverse Battery Protection
- 2 to 5 Cell Alkaline Battery Operated Systems
- USB 1.0, 2.0 and 3.0 Devices
- USB Charging
- Mobile Devices
- Mobile Medical
- Toys
- Any DC Barrel Jack Powered Device
- Any DC Devices subject to Negative Hot Plug or Inductive Transients

Description

Reverse bias is an increasingly common fault event that may be generated by user error, improperly installed batteries, automotive environments, erroneous connections to third-party chargers, negative "hot plug" transients, inductive transients, and readily available negatively biased rouge USB chargers.

Fairchild circuit protection is proud to offer a new type of reverse bias protection devices. The FR devices are low resistance, series switches that, in the event of a reverse bias condition, shut off power and block the negative voltage to help protect downstream circuits.

The FR devices are optimized for the application to offer best in class reverse bias protection and voltage capabilities while minimizing size, series voltage drop, and normal operating power consumption.

In the event of a reverse bias application, FR015L3EZ devices effectively provide a full voltage block and can easily protect -0.3V rated silicon.

From a power perspective, in normal bias, a $15m\Omega$ FR device in a 0.1A application will generate only 1.5mV of voltage drop or 0.15mW of power loss. In reverse bias, FR devices dissipate less then $10\mu W$ in a 3V reverse bias event. This type of performance is not possible with a diode solution.

Benefits extend beyond the device. Due to low power dissipation, not only is the device small, but heat sinking requirements and cost can be minimized as well.

Ordering Information

Part Number	Operating Temperature Range	Top Mark	Package	Packing Method	
FR015L3EZ	-55°C ~ 125°C	019L	6-Lead, Molded Leadless Package (MLP), Dual, Non-JEDEC, 2mm Square, Single-Tied DAP	3000 on Tape & Reel; 7-inch Reel, 12mm Tape	

Diagrams

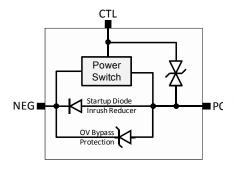


Figure 1. Block Diagram

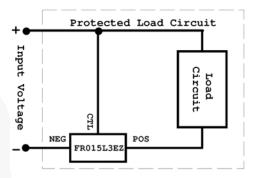
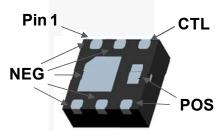


Figure 2. Typical Schematic

Pin Configuration



MicroFET 2x2 mm

Figure 3. Pin Assignments

Pin Definitions

Name	Pin	Description				
POS	4	The ground of the load circuit to be protected. Current flows into this pin during normal bias operation.				
CTL	3	The control pin of the device. A positive voltage on this pin with regard to NEG pin turns the switch on and a negative voltage turns the switch to a high impedance state.				
NEG	1, 2, 5, 6	The ground of the input power source. Current flows out of this pin during normal bias operation.				

Absolute Maximum Ratings Values are at T_A=25°C unless otherwise noted.

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol		Value	Unit				
V+ MAX_OP	Steady-State (V _{IN} = V+ _{MAX}	+8					
V+ ₂₄	24-Hour Normal Operating Voltage Withstand Capability between CTL and NEG Pins (V _{IN} = V+ ₂₄ , I _{IN} = 1.5A, Switch On) (1)					12	V
V- MAX_OP	Steady-State (V _{IN} = V- _{MAX}	-20					
I _{IN}	Input Current		V_{IN}	= 3V, Continuous ⁽²⁾ (see F.	8	Α	
TJ	Operating Junction Temperature					150	°C
P _D	Power Dissipation		$T_A = 25^{\circ}C^{(2)}$ (see Figure 4)			2.4	w
			T _A :	= 25°C ⁽²⁾ (see Figure 5)	0.9	VV	
IDIODE_CONT	Steady-State Diode Continuous Forward Current from POS to NEG					2	^
I _{DIODE_PULSE}	Pulsed Diode Forward Current from POS to NEG (300µs Pulse)					190	Α
	Human Body Model, JESD22-A114					2500	
	Electrostatic Discharge Capability	Charged Devi	ce N	2000			
ESD		charge		POS is shorted to CTL	Contact	5000	
			١,		Air	7000	- V
			2	No external connection	Contact	300	
				between POS and CTL	Air	3000	

Notes:

- 1. The V₊₂₄ rating is NOT a survival guarantee. It is a statistically calculated survivability reference point taken on qualification devices, where the predicted failure rate is less than 0.01% at the specified voltage for 24 hours. It is intended to indicate the device's ability to withstand transient events that exceed the recommended operating voltage rating. Specification is based on qualification devices tested using accelerated destructive testing at higher voltages, as well as production pulse testing at the V₊₂₄ level. Production device field life results may vary. Results are also subject to variation based on implementation, environmental considerations, and circuit dynamics. Systems should never be designed with the intent to normally operate at V₊₂₄ levels. Contact Fairchild Semiconductor for additional information.
- 2. The device power dissipation and thermal resistance (R_{θ}) are characterized with device mounted on the following FR4 printed circuit boards, as shown in Figure 4 and Figure 5







Figure 5. Minimum Pads of 2-ounce Copper

Thermal Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽²⁾ (see Figure 4)	60	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽²⁾ (see Figure 5)	150	C/VV

Electrical Characteristics

Values are at $T_A = 25^{\circ}$ C unless otherwise noted.

Symbol	Para	meter	Conditions	Min.	Тур.	Max.	Unit	
Positive Bias	Characteristics				•	•	•	
R _{oN}			V _{IN} = +1.7V, I _{IN} = 1.5A		22	30		
			V _{IN} = +2.1V, I _{IN} = 1.5A		18	25	mΩ	
	Device Resistanc	e Switch On	V _{IN} = +3V, I _{IN} = 1.5A		15	20		
	Device resistant	c, owner on	V _{IN} = +5V, I _{IN} = 1.5A		14	19		
			V _{IN} = +3V, I _{IN} = 1.5A, T _J = 125°C		22	30		
Von	Input Voltage, V _{IN} at POS, V _{POS} , Re Level at Given Cu		I _{IN} = 100mA, V _{POS} = 50mV, V _{NEG} = 0V	0.7	1.0	1.3	V	
ΔV_{ON} / ΔT_{J}	Temperature Coe	fficient of V _{ON}			-1.7		mV/°C	
I _{DIODE_CONT}	Continuous Diode	Forward Current	V _{CTL} = V _{POS}			2	Α	
V_{F}	Diode Forward Vo	oltage	V _{CTL} = V _{POS} , I _{DIODE} = 3A, Pulse width < 300µs	0.65	0.80	0.95	V	
I _{BIAS}	Bias Current Flow Pin during Norma	•	V_{CTL} = 8V, V_{NEG} = 0V, No Load			10	μA	
Negative Bias	Characteristics							
V- _{MAX_OP}	Reverse Bias Bre	akdown Voltage				-20	V	
ΔV - MAX_OP / ΔT_J	Reverse Bias Bre Temperature Coe		$I_{IN} = -250 \mu A$, $V_{CTL} = V_{POS} = 0V$		16		mV/°C	
l-	Leakage Current in Reverse-Bias C	from NEG to POS Condition	$V_{NEG} = 16V,$ $V_{CTL} = V_{POS} = 0V$			1	μA	
t _{RN}	Time to Respond Condition	to Negative Bias	V_{NEG} = 2.7V, V_{CTL} = 0V, C_{LOAD} = 10 μ F, Reverse Bias Startup Inrush Current = 0.2A			50	ns	
Integrated TV	S Performance							
V_Z	Breakdown Voltag	ge @ I _⊺	$I_T = 1mA$	12	13	14.5	V	
1_	Leakage Current	from CTL to POS,	$V_{CTL} - V_{POS} = 8V$		2	10	μΔ	
I _R	NEG is Open		$V_{CTL} - V_{POS} = -8V$		-2	-10	μA	
I _{PPM}	Max Pulse		V _{CTL} > V _{POS}			0.6	╛.	
	Current from CTL to POS	IEC61000-4-5	V _{CTL} < V _{POS}			0.4	Α	
	Clamping	8x20µs pulse, NEG is Open	V _{CTL} > V _{POS}			15.0		
V _C	Voltage form CTL to POS	NEO 13 Open	V _{CTL} < V _{POS}			14.3	V	
Dynamic Cha	racteristics						\prec	
Cı	Input Capacitance and NEG	e between CTL	$V_{IN} = 3V$, $V_{NEG} = V_{POS} = 0V$, $f = 1MHz$		900	1	3/	
Cs	Switch Capacitan and NEG	ce between POS			133		pF	
Co	Output Capacitan and POS	ce between CTL			967			
R _C	Control Internal R	esistance			2		Ω	

Typical Characteristics

 $T_J = 25$ °C unless otherwise specified.

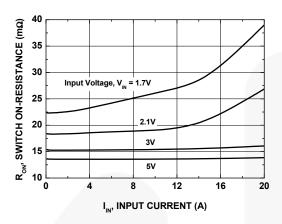


Figure 6. Switch On Resistance vs. Switch Current

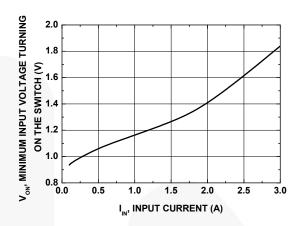


Figure 7. Minimum Input Voltage to Turn On Switch vs. Current at 50mV Switch Voltage Drop

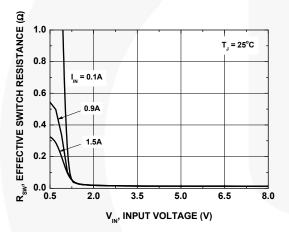


Figure 8. Effective Switch Resistance R_{SW} vs. Input Voltage V_{IN}

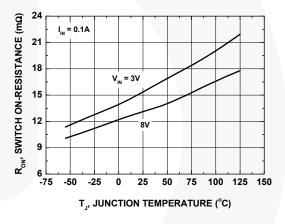


Figure 9. Switch On Resistance vs. Junction Temperature at 0.1A

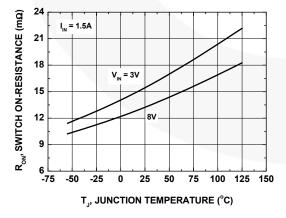


Figure 10. Switch On Resistance vs. Junction Temperature at 1.5A

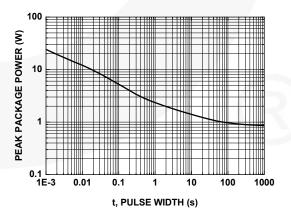


Figure 11. Single-Pulse Maximum Power vs. Time

Typical Characteristics (Continued)

 T_J = 25°C unless otherwise specified.

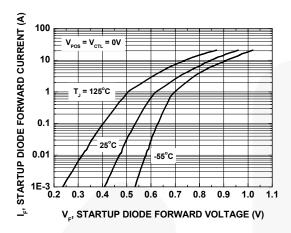


Figure 12. Startup Diode Current vs. Forward Voltage

Application Test Configurations

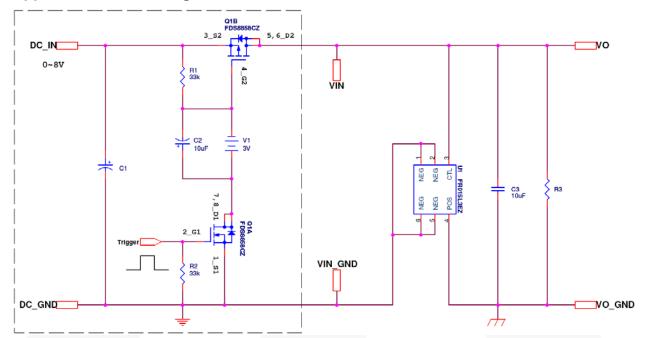


Figure 13. Startup Test Circuit - Normal Bias with FR015L3EZ Device

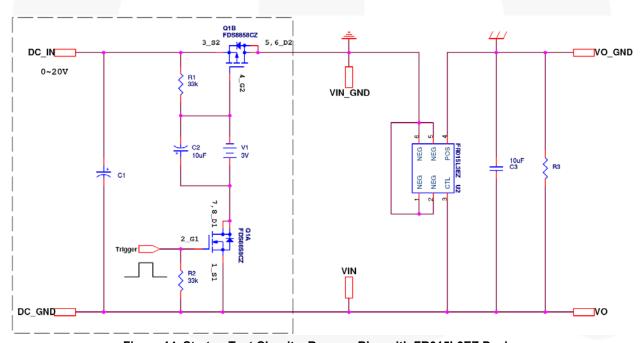


Figure 14. Startup Test Circuit – Reverse Bias with FR015L3EZ Device

Application Test Configurations

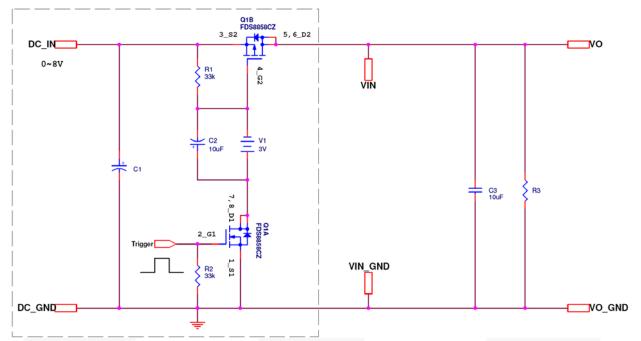


Figure 15. Startup Test Circuit - No Reverse Polarity Protection

Typical Application Waveforms

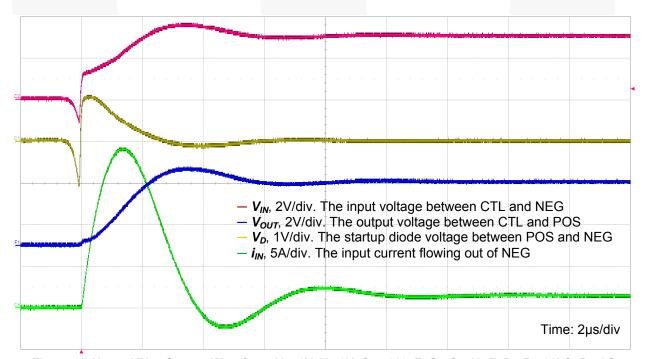


Figure 16. Normal Bias Startup Waveform, V_{IN} =3V, V_1 =3V, C_1 =5200 μ F, C_2 = C_3 =10 μ F, R_1 = R_2 =33k Ω , R_3 =2 Ω



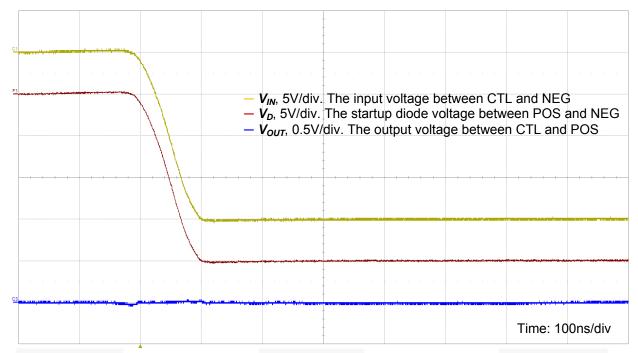


Figure 17. Reverse Bias Startup Waveform, V_{IN} =3V, V_1 =3V, C_1 =5200 μ F, C_2 = C_3 =10 μ F, R_1 = R_2 =33k Ω , R_3 =2 Ω

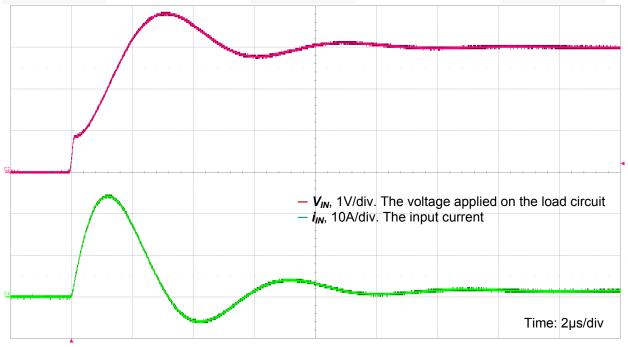


Figure 18. Startup Waveform without FR015L3EZ Device, V_{IN} =3V, V_1 =3V, C_1 =5200 μ F, C_2 = C_3 =10 μ F, R_1 = R_2 =33k Ω , R_3 =2 Ω

Application Information

The FR015L3EZ is capable of being turned on at a voltage as low as 1.5V, therefore is especially suitable for low voltage application like AA, AAA or single lithium-ion battery operated devices. The voltage and current waveforms in Figure 16 and Figure 18 are both captured with a 2Ω load at 3V input.

When the DC power source is connected to the circuit (refer to Figure 1 and Figure 2), the built-in startup diode initially conducts the current such that the load circuit powers up. Due to the initial diode voltage drop, the FR015L3EZ effectively reduces the peak inrush current of a hot plug event. Under these test conditions, the input inrush current reaches about 19A peak. While the current flows, the input voltage increases. The speed of this input voltage increase depends on the time constant formed by the load resistance R₃ and load capacitance C₃, assuming the input voltage source holds itself during turn on. The larger the time constant, the slower the input voltage increase. As the input voltage approaches a level equal to the protector's turn-on voltage, V_{ON}, the protector turns on and operates in Low-Resistance Mode as defined by V_{IN} and operating current I_{IN}.

In the event of a negative voltage transient between CTL and NEG, or when the DC power source, V_{IN} , is reversely connected to the circuit, while no residual voltage presents between CTL and POS, the device blocks the flow of current and holds off the voltage, thereby protecting the load circuit. Figure 17 shows the startup waveforms while a passive load circuit is reversely biased. It can be clearly seen that the output voltage is near 0 or at a level that is harmless to the load circuit.

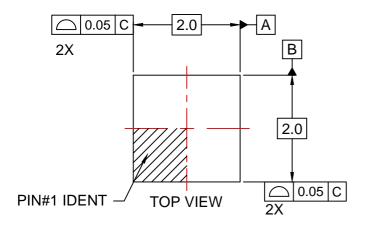
Figure 18 shows the voltage and current waveforms when no reverse bias protection is implemented. In

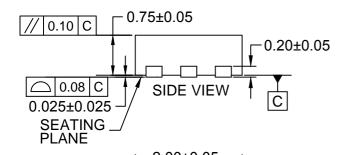
Figure 16, while the reverse bias protector is present, the input voltage, V_{IN} , and the output voltage, V_{O} , are separated and look different. When this reverse bias protector is removed, V_{IN} and V_{O} merge, as shown in Figure 18 as V_{IN} . This V_{IN} is also the voltage applied to the load circuit. It can be seen that, with reverse bias protection, the voltage applied to the load and the current flowing into the load look very much the same as without reverse bias protection.

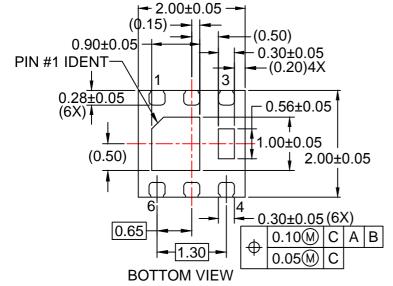
In Figure 16, negative voltage spikes are seen on V_{IN} and V_{D} before V_{IN} starts to rise from 0; and in both Figures 16 and 18, negative input current is seen after FR015L3EZ is fully turned on. These phenomena are a combined effect of parasitic inductance and all the capacitors in the input voltage control circuit enclosed in the broken line as shown in Figures 13 to 15. This is not a problem as long as the load circuit doesn't see a negative voltage at anytime, which is what the reverse bias protector is meant for. Indeed, we can see from Figures 16 and 18, the output voltage on the load circuit is always equal to or greater than 0V.

Benefits of Reverse Bias Protection

The most important benefit is, of course, to prevent accidently reverse-biased voltage from damaging the load circuit. Another benefit is that the peak startup inrush current can be reduced. How fast the input voltage rises, the input/output capacitance, the input voltage, and how heavy the load is determine how much the inrush current can be reduced. In this specific 3V / 2A application, for example, the inrush current has been reduced from 24A to 19A, a 21% reduction. This can offer a system designer the option of increasing C₃ while keeping "effective" load circuit capacitance down.

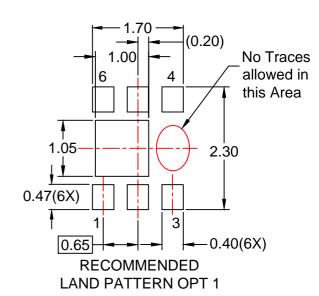


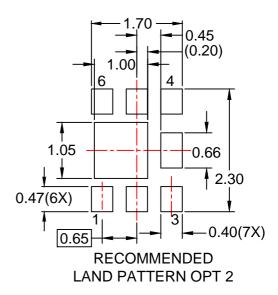




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